

N-Channel 100 V (D-S) Super Junction Power MOSFET

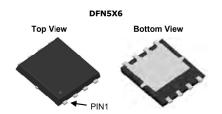
PRODUCT SUMMARY						
V _{DS} (V)	$V_{DS}(V)$ $R_{DS(on)}(m\Omega)(Typ.)$		Q _g (Typ.)			
100	10 at V _{GS} = 10 V	50	18nC			

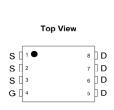
FEATURES

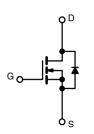
- DT-SJ Power MOSFET
- 100 % Rgand UIS Tested

APPLICATIONS

- DC/DC converters
- Primary side switch







N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S (TA = 25 °C, U	inless other	wise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	100	V	
Gate-source voltage		V _{GS}	± 20	v	
	T _C = 25 °C		50 ^a		
Continuous dusin suggest (T. 150 °C)	T _C = 70 °C] ,	38 a		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	- I _D	9 b, c		
	T _A = 70 °C	1	5.5 b, c	\neg	
Pulsed drain current (t = 100 μs)		I _{DM}	180	A	
Continuous source drain diada surrent	T _C = 25 °C	- I _S	50 ^a		
Continuous source-drain diode current	T _A = 25 °C		8.6 b, c		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	48		
Single pulse avalanche energy		E _{AS}	93	mJ	
	T _C = 25 °C		65		
Maximum navvar disabation	T _C = 70 °C	P _D	50	w	
Maximum power dissipation	T _A = 25 °C		2.25 ^{b, c}	vv	
	T _A = 70 °C		1.8 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	PICAL MAXIMUM		
Maximum junction-to-ambient b	t ≤ 10 s	R _{thJA}	40	50		
Maximum junction-to-case	Steady state	R _{thJC}	1.2	2	°C/W	

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board. c. t = 10 s.
- d. Calculated based on maximum junction temperature.



PARAMETER	SYMBOL	therwise noted) OL TEST CONDITIONS		TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	-	56	-		
V _{GS(th)} temperature coefficient	ΔV _{GS(th)} /T _J	I _D = 250 μA	-	-6	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2	-	4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA	
		V _{DS} = 100 V, V _{GS} = 0 V	-	-	1	μА	
Zero gate voltage drain current	I _{DSS}	V_{DS} = 80 V, V_{GS} = 0 V, T_{J} = 75 °C	-	-	10		
On-state drain current ^a			50	-	-	Α	
Drain-source on-state resistance a	R _{DS(cn)}	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	10	13	mΩ	
Forward transconductance ^a	9 _{fs}	$V_{DS} = 5 \text{ V}, I_D = 20 \text{ A}$	-	25	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	1185	-		
Output capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	660	-	pF	
Reverse transfer capacitance	C _{rss}		-	15	-		
Total gate charge	Q_g		-	18	-		
Gate-source charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	5	-	nC	
Gate-drain charge	Q _{gd}		-	3.6	-		
Output charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$	-	49	-		
Gate resistance	R _q	f = 1 MHz	-	0.8	-	Ω	
Turn-on delay time	t _{d(on)}		-	13	-		
Rise time	t _r	$V_{DD} = 50 \text{ V}, \text{ R}_L = 2.5 \Omega, \text{ I}_D \cong 20 \text{ A},$	-	14	-	ns	
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	35	-		
Fall time	t _f		-	9	-		
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	50		
Pulse diode forward current (t _p = 100 μs)	I _{SM}		-	-	180	Α	
Body diode voltage	V _{SD}	$I_S = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.7	1.2	V	
Body diode reverse recovery time	t _{rr}			54	-	ns	
Body diode reverse recovery charge	Q _{rr}	1 00 A di/d+ 100 A/va T 05 °C	-	76	-	nC	
Reverse recovery fall time	ta	$I_F = 20 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		27	-		
Reverse recovery rise time	t _b		-	27	-	ns	

Notes

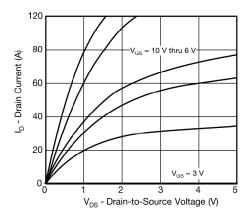
a.P ulse test; pulse width \leq 300 µs, duty cycle \leq 2 %

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

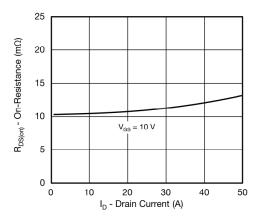
b. Guaranteed by design, not subject to production testing



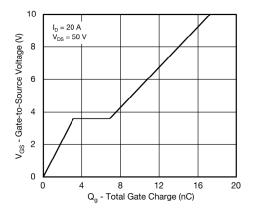
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



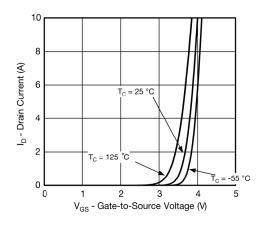
Output Characteristics



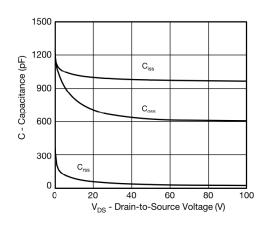
On-Resistance vs. Drain Current and Gate Voltage



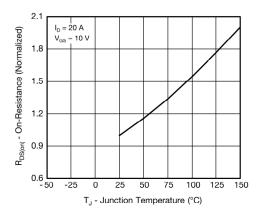
Gate Charge



Transfer Characteristics



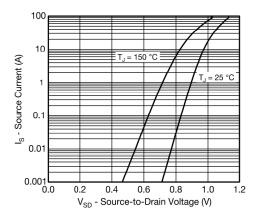
Capacitance



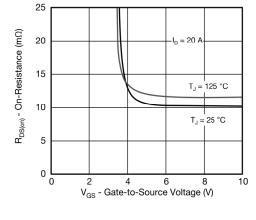
On-Resistance vs. Junction Temperature



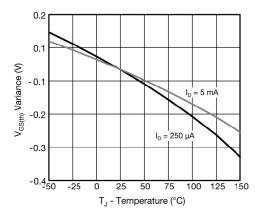
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



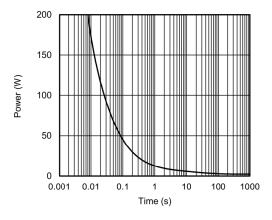
Source-Drain Diode Forward Voltage



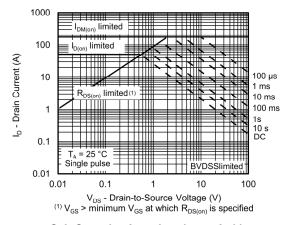
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



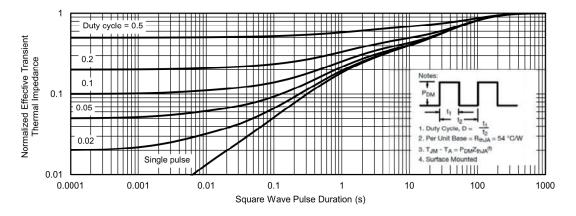
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient





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